



**WANSEMI**  
万芯半导体

**WP3402ASS**

# **Enhancement Mode N-Channel Power MOSFET**

**SOT23/NMOS/30V/ $\pm 12V$ /1.0V/4A/37m $\Omega$**

**Rev0.6**

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## 30V,37mΩ,4A, N-Channel MOSFET

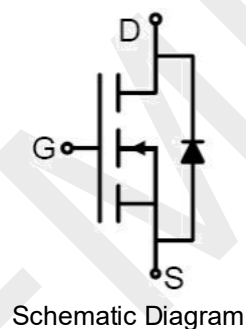
### 1.Features

- ◆ Advanced Trench Technology
- ◆ Surface mount package

### 2.Applications

- ◆ Power Management
- ◆ Load Switching

VDS	RDS(on) Typ.	ID.
30V	37mΩ @ 10V	4A
	39mΩ @ 4.5V	
	47mΩ @ 2.5V	



### 3.Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP3402ASS	3402A	SOT23	3,000	180,000

### 4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{DSS}$	30	V
Gate to Source Voltage	$V_{GSS}$	±12	V
Drain Current (DC)	$I_D$	4	A
Drain Current (Pulse), $PW \leq 300\mu s$	$I_{DP}$	16	A
Total Dissipation	$P_D$	1.2	W
Junction Temperature	$T_j$	150	°C
Storage Temperature	$T_{stg}$	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

**5. Thermal Resistance Ratings (Note 2)**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	103	$^{\circ}\text{C/W}$

Note 2: When mounted on 1 inch square copper board  $t \leq 10\text{sec}$  The value in any given application depends on the user's specific board design.

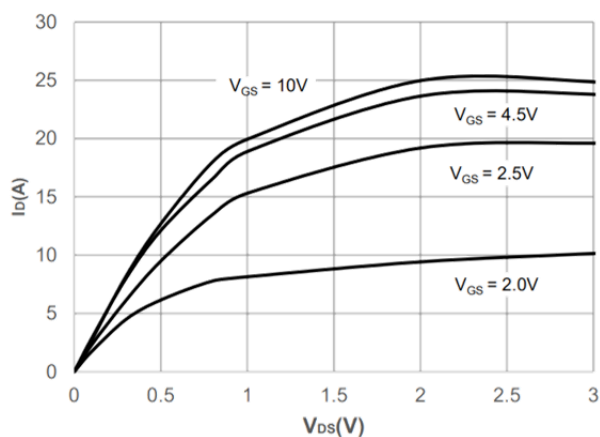
**6. Electrical Characteristics at  $T_a=25^{\circ}\text{C}$  (Note 3)**

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = 250\mu\text{A}$ , $V_{GS} = 0\text{V}$	30	-	-	V
Zero-Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 30\text{V}$ , $V_{GS} = 0\text{V}$	-	-	1	$\mu\text{A}$
Gate to Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 12\text{V}$ , $V_{DS} = 0\text{V}$	-	-	$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$ , $I_{DS}=250\mu\text{A}$	0.4	1.0	1.4	V
Static Drain to Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{V}$ , $I_D = 4\text{A}$	-	37	45	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}$ , $I_D = 3\text{A}$	-	39	50	$\text{m}\Omega$
		$V_{GS} = 2.5\text{V}$ , $I_D = 3\text{A}$	-	47	70	$\text{m}\Omega$
Input Capacitance	$C_{iss}$	$V_{GS}=0\text{V}$ , $V_{DS}=15\text{V}$ , Frequency=1.0MHz	-	414	-	pF
Output Capacitance	$C_{oss}$		-	36	-	pF
Reverse Transfer Capacitance	$C_{rss}$		-	29	-	pF
Turn-ON Delay Time	$t_{d(on)}$	$V_{DD} = 15\text{V}$ , $I_D = 2\text{A}$ , $V_{GS} = 4.5\text{V}$ , $R_{GEN} = 3\Omega$	-	4	-	ns
Rise Time	$t_r$		-	13	-	ns
Turn-OFF Delay Time	$t_{d(off)}$		-	41	-	ns
Fall Time	$t_f$		-	17	-	ns
Total Gate Charge	$Q_g$	$V_{DS} = 15\text{V}$ , $V_{GS} = 4.5\text{V}$ , $I_D = 2\text{A}$	-	4.5	-	nC
	$Q_{gs}$		-	1	-	nC
	$Q_{gd}$		-	1	-	nC
Diode Forward Voltage	$V_{FSD}$	$I_S = 4\text{A}$ , $V_{GS} = 0\text{V}$	0.5	0.85	1.4	V

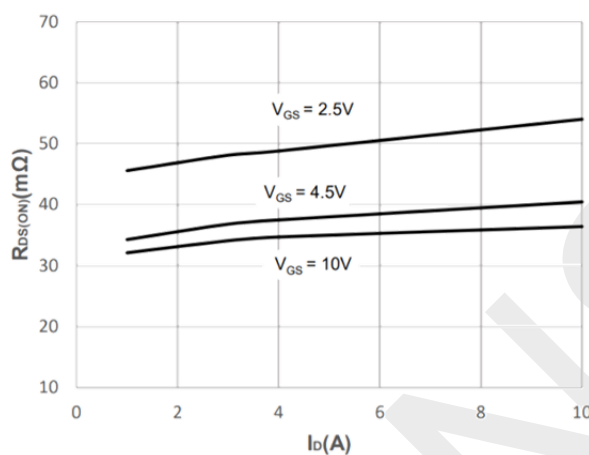
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



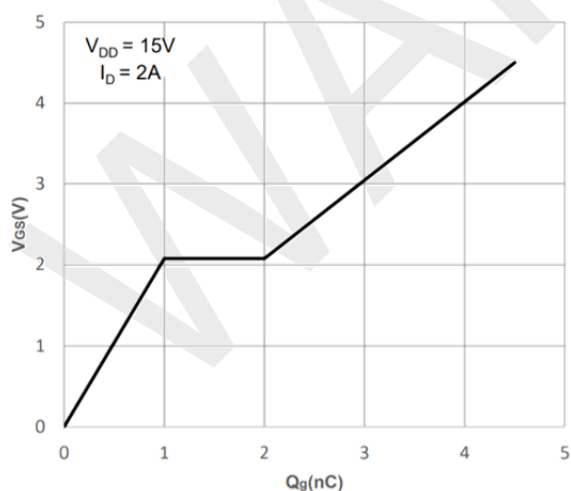
## 7. Typical Electrical and Thermal Characteristics



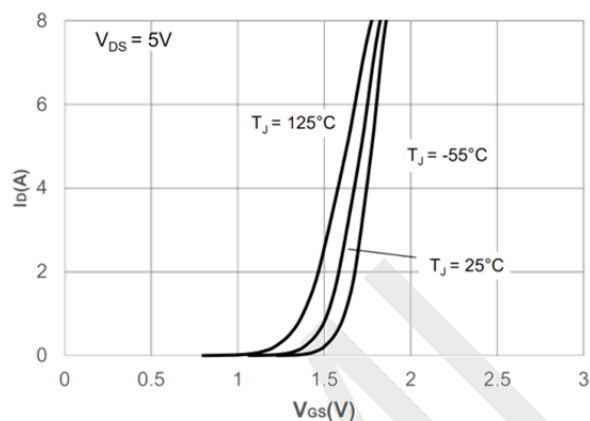
Output Characteristics



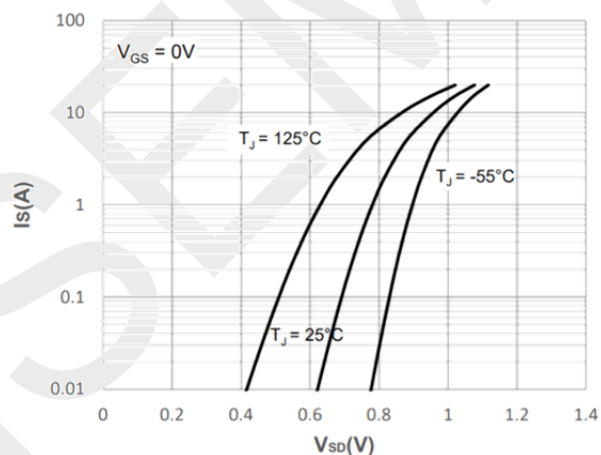
On-resistance vs. Drain Current



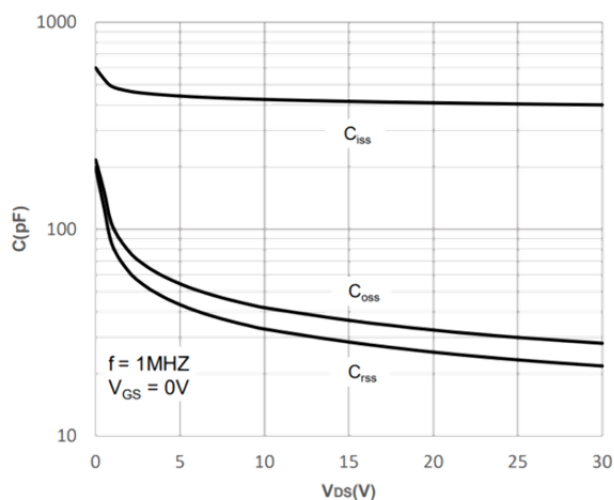
Gate Charge Characteristics



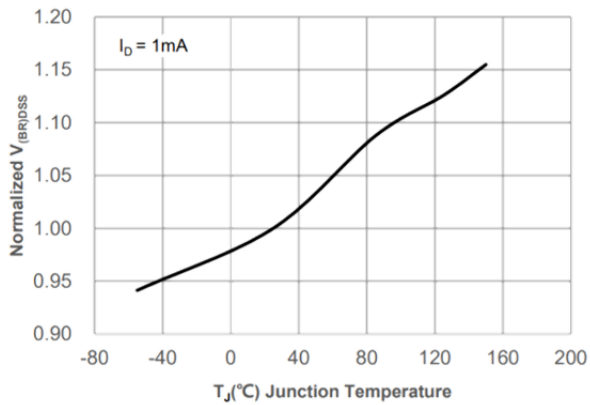
Typical Transfer Characteristics



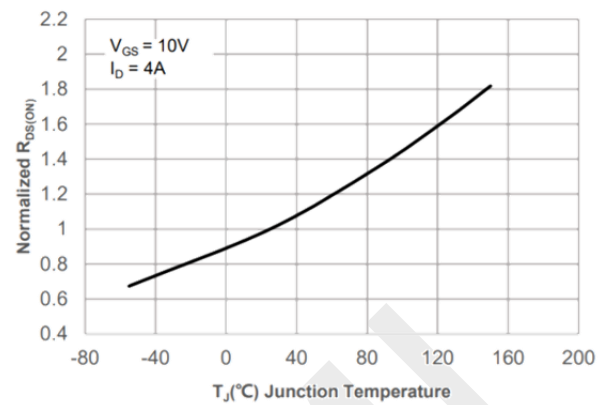
Body Diode Characteristics



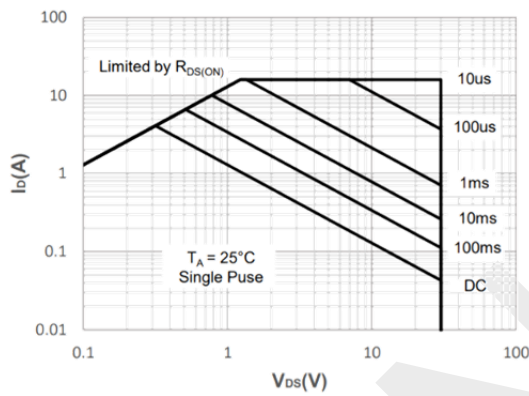
Capacitance Characteristics



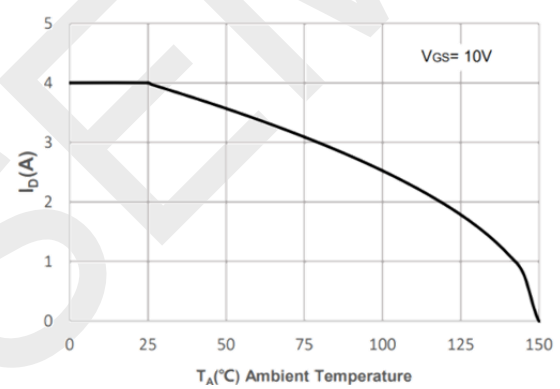
Normalized Breakdown Voltage vs.  
Junction Temperature



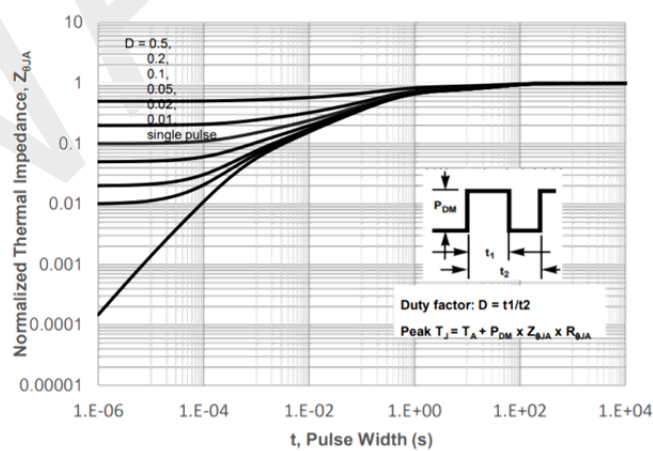
Normalized on Resistance vs.  
Junction Temperature



Maximum Safe Operating Area



Maximum Continuous Drain Current vs.  
Case Temperature

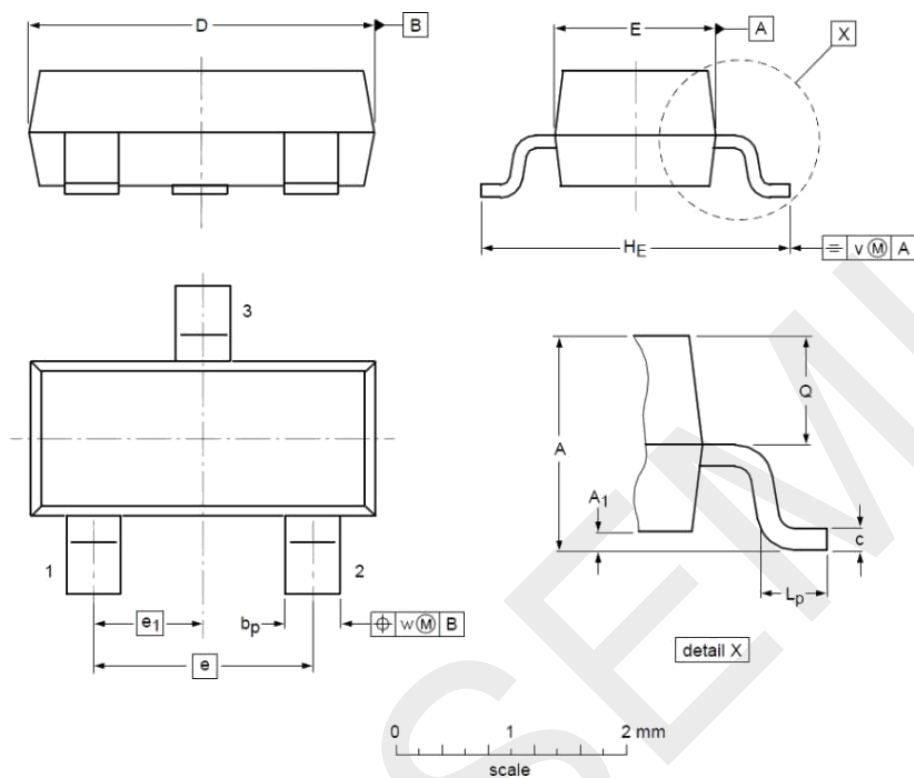


Maximum Effective Transient

Thermal Impedance, Junction-to-Case



## 8.Package Dimensions



DIMENSIONS ( unit : mm )

Symbol	Min	Typ	Max	Symbol	Min	Typ	Max
A	0.90	1.01	1.15	A <sub>1</sub>	0.01	0.05	0.10
b <sub>p</sub>	0.30	0.42	0.50	c	0.08	0.13	0.15
D	2.80	2.92	3.00	E	1.20	1.33	1.40
e	--	1.90	--	e <sub>1</sub>	--	0.95	--
H <sub>E</sub>	2.25	2.40	2.55	L <sub>p</sub>	0.30	0.42	0.50
Q	0.45	0.49	0.55	v	--	0.20	--
w	--	0.10	--				

## **9.Important Notice**

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